

SEMITOP®E2

Half-Bridge (Full SiC)

Engineering Sample SK200MB120CR03TE2

Target Data

Features*

- Optimized design for superior thermal performance
- Extremely low inductance design
- Press-Fit contact technology
- 1200V Planar Gen3 SiC MOS
- Simple to drive with +15V gate voltage
- Integrated NTC temperature sensor
- UL recognized file no. E 63 532

Typical Applications

- · Switched Mode Power Supplies
- Energy Storage Systems
- Electric Vehicle charging
- UPS
- Solar
- Motor Drives

Remarks

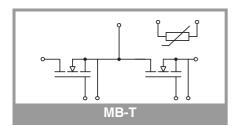
- Recommended T_{i,op}=-40 ...+150 °C
- Recommended turn-off / turn-on gate voltage V_{GS} = -4...0/+15V

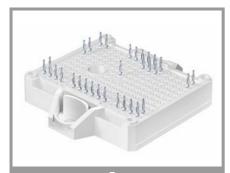
Footnotes

¹⁾ SEMIKRON Exclusive High Performance Thermal Paste (HPTP), available as pre-applied

Absolute Maximum Ratings						
Symbol	Conditions		Values	Unit		
MOSFET 1						
V_{DSS}			1200	V		
I _D	T _j = 175 °C	T _s = 25 °C	218	Α		
		T _s = 70 °C	182	Α		
I _{DM}	Pulse width t _p limited by T _{jmax}		600	Α		
I _{DM,repetitive}			320	Α		
V _{GS}	Max. transient gate - source voltage		-8 19	V		
Tj			-55 175	°C		
Integrated body diode						
I _{FM}	Pulse width t _p limited by T _{jmax}		600	Α		
I _{FM,repetitive}			320	Α		

Absolute Maximum Ratings					
Symbol	Conditions	Values	Unit		
Module					
I _{t(RMS)}	ΔT _{terminal} at PCB joint = 30 K, per pin	30	Α		
T _{stg}		-40 125	°C		
V _{isol}	AC, sinusoidal, t = 1 min	2500	V		





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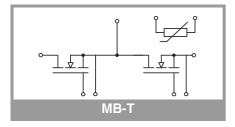
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Characteristics							
Symbol	Conditions		min.	typ.	max.	Unit	
MOSFET 1							
$V_{(BR)DSS}$	$V_{GS} = 0 \text{ V}, I_D = 0.1 \text{ mA}, T_j = 25 \text{ °C}$		1200			V	
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 57.5$ mA, $T_j = 25$ °C		1.8	2.5	3.6	V	
I _{DSS}	$V_{GS} = 0 \text{ V}, V_{DS} = 1200 \text{ V}, T_j = 25 \text{ °C}$				1	mA	
I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = 15 \text{ V}, T_j = 25 \text{ °C}$				500	nA	
R _{DS(on)}	$V_{GS} = 15 \text{ V}$	T _j = 25 °C		6.4	8.6	mΩ	
	I _D = 207 A chiplevel	T _j = 150 °C		10		mΩ	
C _{iss}	$V_{GS} = 0 \text{ V}, V_{DS} = 10$	000 V, f = 0.1 MHz		17000		pF	
Coss	V _{GS} = 0 V, V _{DS} = 1000 V, f = 0.1 MHz			650		pF	
C _{rss}	$V_{GS} = 0 \text{ V}, V_{DS} = 10$	000 V, f = 0.1 MHz		50		pF	
R _{Gint}	T _j = 25 °C			2.7		Ω	
Q _G	$V_{DD} = 800 \text{ V}, V_{GS} = I_{D} = 207 \text{ A}$: -4 V 15 V,	590			nC	
t _{d(on)}	$di/dt_{on} = 18 \text{ kA/µs}$ $di/dt_{on} = 18 \text{ kV/µs}$ $dv/dt = 28 \text{ kV/µs}$	T _j = 150 °C		49		ns	
t _{d(off)}		T _j = 150 °C		120		ns	
t _r		T _j = 150 °C		17	ns		
t _f		T _j = 150 °C		29			
Eon		T _j = 150 °C		2.47		mJ	
E _{off}		T _j = 150 °C		2.14		mJ	
R _{th(j-s)}	per MOSFET, λ_{past}	_e =2.5 W/(mK) ¹⁾		0.25		K/W	
Integrated	l body diode						
$V_F = V_{SD}$	-I _D = 104 A	T _j = 25 °C		4.6		V	
	V _{GS} = -4 V chiplevel	T _j = 150 °C	4.3		V		
$V_{F0} = V_{SD0}$	chiplevel	T _j = 25 °C		3.8		V	
	Chipievei	T _j = 150 °C	3.6		V		
$r_F = r_{SD}$	chiplevel	T _j = 25 °C	7.7		mΩ		
	Cnipievei	T _j = 150 °C		6.8		mΩ	
t _{rr}	V _{DD} = 600 V	T _j = 150 °C		40		ns	
Q _{rr}	$I_{O} = 200 \text{ A}$ $V_{GS} = -4 \text{ V}$ $I_{O} = 0.6 \Omega$	T _j = 150 °C		5.6		μC	
I _{rr}		T _j = 150 °C		281		Α	
E _{rr}	di/dt _{off} = 19 kA/μs	T _j = 150 °C		1.84		mJ	
	<u> </u>	<u> </u>					

Characteristics						
Symbol	Conditions	min.	typ.	max.	Unit	
Module						
L _{CE}			6		nΗ	
Ms	to heatsink	1.6		2.3	Nm	
w	weight		35		g	

Characteristics						
Symbol	Conditions	min.	typ.	max.	Unit	
Temperature Sensor						
R ₁₀₀	T _r = 100 °C	493 ± 5%			Ω	
B _{100/125}	$R_{(T)}=R_{100}exp[B_{100/125}(1/T-1/T_{100})]; T[K];$	3550 ±2%		К		



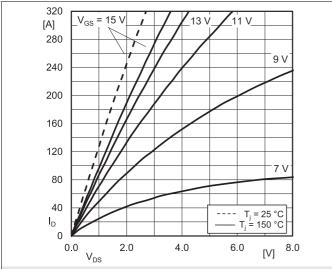


Fig.1: Typ. MOSFET forward output characteristic, incl. $R_{\text{DD}'\text{+-}SS'}$

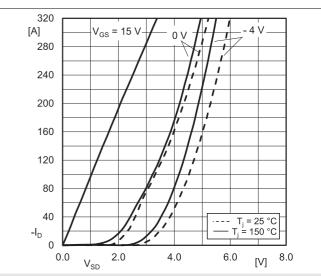


Fig. 2: Typ. MOSFET reverse output characteristics, incl. $R_{\text{DD}'+\,\text{SS}'}$

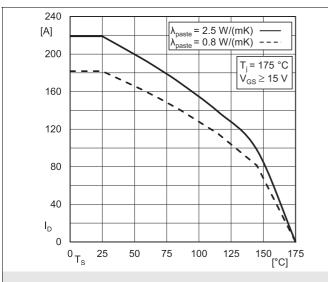


Fig. 3: Rated current vs. temperature $I_D = f(T_S)$

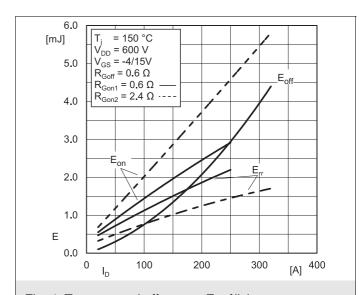


Fig. 4: Typ. turn-on/-off energy $E = f(I_D)$

 $T_j = 25 \, ^{\circ}\text{C}$ $T_i = 175 \, ^{\circ}\text{C}$

≤ 200 µs

 $V_{DS} = 20V$

600

480

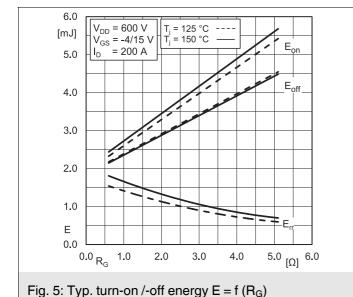
360

240

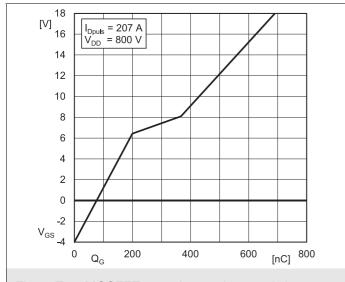
120

Ι_D 0

[A]



12 _[V] 14



Flg. 7: Typ. MOSFET gate charge characteristic

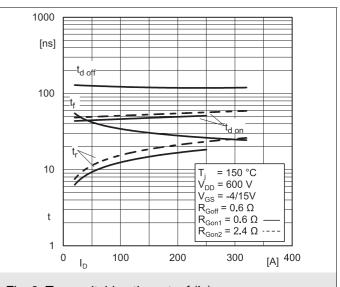


Fig. 8: Typ. switching times $t = f(I_D)$

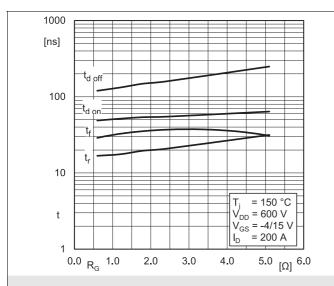


Fig. 9: Typical switching times $t = f(R_G)$

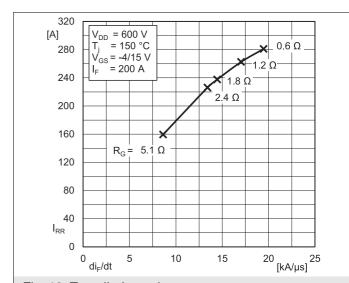


Fig. 10: Typ. diode peak reverse recovery current $I_{RR} = f \left(di_F/dt \right)$

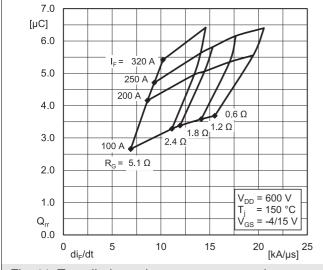


Fig. 11: Typ. diode peak reverse recovery charge $Q_{RR} = f(di_F/dt)$

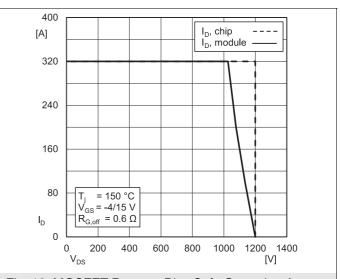
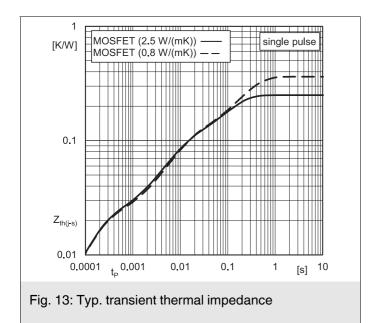
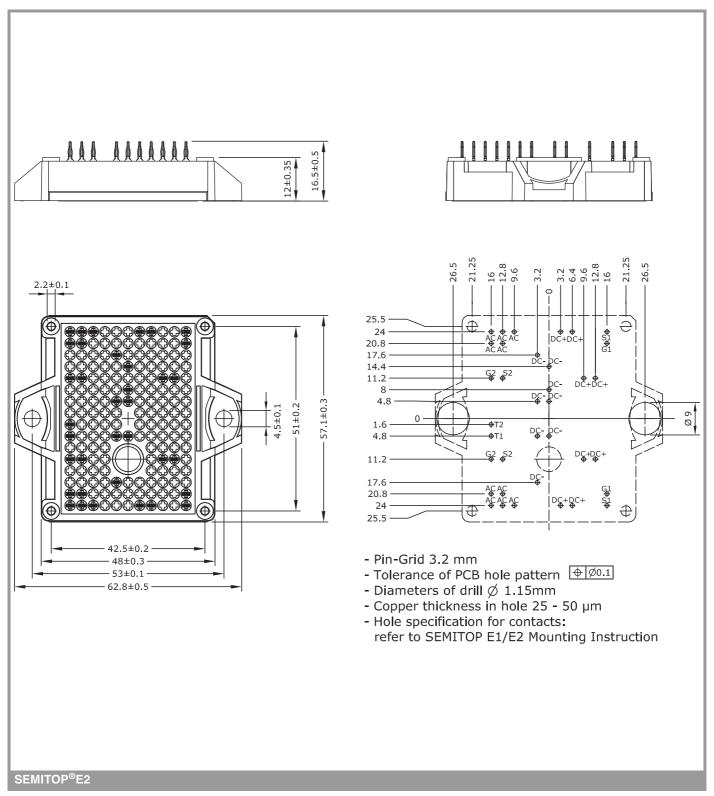
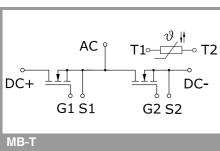


Fig. 12: MOSFET Reverse Bias Safe Operating Area (RBSOA)







This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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